

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
FUKUSHIMA ET AL.

Examiner

Kimbinh T. Nguyen

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number		Date	Name	Classification
		Country Code-Number-Kind Code		MM-YYYY		
*	A	US-2007/0122027		05-2007	Kunita et al.	382/154
	B	US-				
	C	US-				
	D	US-				
	E	US-				
	F	US-				
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**FOREIGN PATENT DOCUMENTS**

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